

# **Excellent Integrated System Limited**

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Fairchild Semiconductor DM74ALS37AN

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# DM74ALS37A Quadruple 2-Input NAND Buffer

#### **General Description**

This device contains four independent gates, each of which performs the logic NAND function.

September 1986 Revised February 2000

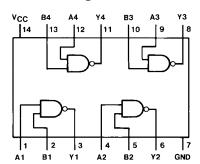
#### Features

- Switching specifications at 50 pF
- Switching specifications guaranteed over full temperature and V<sub>CC</sub> range
- Advanced oxide-isolated, ion-implanted Schottky TTL process
- Functionally and pin for pin compatible with LS TTL counterpart
- Improved AC performance over LS37
- Improved line receiving characteristics

### **Ordering Code:**

Order Number	Package Number	Package Description		
DM74ALS37AM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow		
DM74ALS37AN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide		
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.				

### **Connection Diagram**



# Function Table

	$\mathbf{Y} = \overline{\mathbf{AB}}$		
Inp	Inputs		
Α	В	Y	
L	L	Н	
L	Н	н	
н	L	н	
Н	Н	L	

H = HIGH Logic Level L = LOW Logic Level

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## Absolute Maximum Ratings(Note 1)

Supply Voltage	7V
Input Voltage	7V
Operating Free Air Temperature Range	0°C to +70°C
Storage Temperature Range	$-65^\circ C$ to $+150^\circ C$
Typical $\theta_{JA}$	
N Package	83.0°C/W
M Package	114.0°C/W

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

## **Recommended Operating Conditions**

Symbol	Parameter	Min	Nom	Max	Units
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	V
V <sub>IH</sub>	HIGH Level Input Voltage	2			V
V <sub>IL</sub>	LOW Level Input Voltage			0.8	V
l <sub>он</sub>	HIGH Level Output Current			-2.6	mA
OL	LOW Level Output Current			24	mA
T <sub>A</sub>	Free Air Operating Temperature	0		70	°C

## **Electrical Characteristics**

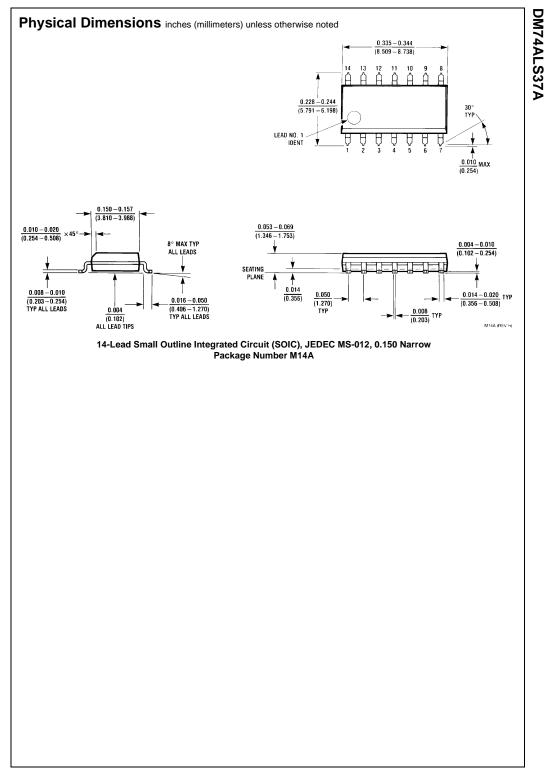
over recommended operating free air temperature range. All typical values are measured at  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ .

Symbol	Parameter Input Clamp Voltage	Conditions		Min	Тур	Max	Units
V <sub>IK</sub>		$V_{CC} = 4.5V, I_I = -18 \text{ mA}$				-1.5	V
V <sub>OH</sub>	HIGH Level Output Voltage	V <sub>CC</sub> = 4.5V V <sub>IL</sub> = Max	I <sub>OH</sub> = -2.6 mA	2.4	3.3		V
		I <sub>OH</sub> = -400 μA		V <sub>CC</sub> – 2			V
V <sub>OL</sub>	LOW Level	$V_{CC} = 4.5V$	I <sub>OL</sub> = 12 mA		0.25	0.4	V
	Output Voltage	$V_{IH} = 2V$	I <sub>OL</sub> = 24 mA		0.35	0.5	V
h	Input Current @ Maximum Input Voltage	$V_{CC} = 5.5V, V_{IH} = 7V$				0.1	mA
I <sub>IH</sub>	HIGH Level Input Current	$V_{CC} = 5.5V, V_{IH} = 2.7V$				20	μΑ
I <sub>IL</sub>	LOW Level Input Current	$V_{CC} = 5.5V, V_{IL} = 0.4V$				-0.1	mA
I <sub>O</sub>	Output Drive Current	$V_{CC} = 5.5V$	V <sub>O</sub> = 2.25V	-30		-112	mA
I <sub>CCH</sub>	Supply Current with Outputs HIGH	$V_{CC} = 5.5V, V_{I} = 0V$	·		0.86	1.6	mA
ICCL	Supply Current with Outputs LOW	$V_{CC} = 5.5V, V_1 = 4.5V$			4.0	7.8	mA

### **Switching Characteristics**

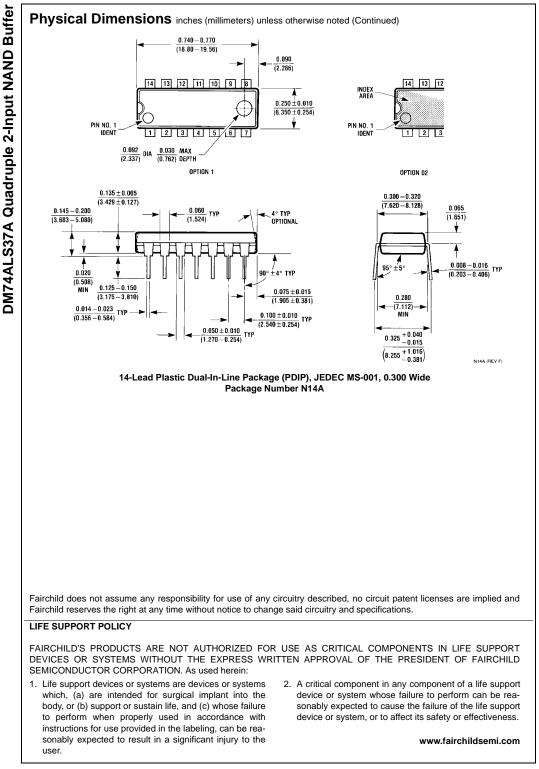
over recommended operating free air temperature range						
Symbol	Parameter	Conditions	Min	Max	Units	
t <sub>PLH</sub>	Propagation Delay Time LOW-to-HIGH Level Output	$V_{CC} = 4.5V$ to 5.5V $R_L = 500\Omega$	2	8	ns	
t <sub>PHL</sub>	Propagation Delay Time HIGH-to-LOW Level Output	C <sub>L</sub> = 50 pF	2	7	ns	





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